

Nicolas Hayen, DAPHNE4NFDI, Kiel University



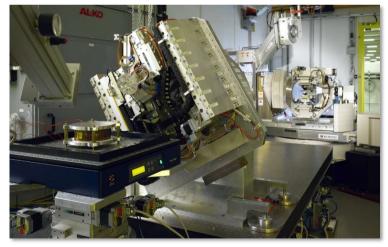
## **Beamline P08 / LISA**



Experiments for X-ray reflectivity use case are performed at beamline P08/DESY at LISA diffractometer

- P08 as a test environment for DAPHNE solutions
- ☐ High resolution beamline, suited for XRR
- ☐ Liquid Interface Scattering Apparatus LISA:
  - Double Crystal Deflector (DCD)
  - > Suitable of XRR experiments at liquid samples







## **Managing Metadata Collection Workflow**



Enabling re-use and repeatability of results, ideally searchable

### **Before experiment**

#### **Proposal**

- Proposal number (ID)
- Science motivation
- Experiment concept
- Technique(s)
- Sample(s)
- Sample environment
- Instrumentation
- Science team

### **Facility**

- Which facility?
- Beam parameters
- Instrumentation
- Detectors

#### **Digital Sample ID**

- 'DOI for samples'
- (MX has sample QR codes)
- Cross link to other consortia

### **During experiment**

#### Facility/machine logs

- Experiment ID (directory)
- Beam parameters
- Motor positions
- Instrument configuration
- Sample environment
- Detector calibration

#### **User record of experiment**

- Instrumentation configuration
- Actual samples used
  - Ideally a digital sample ID
- Actual sample environment
- Changes to original plan
- What happened when
- Run log (data lookup table)
- Currently: Paper logbooks, google sheets, confluence, and more

## After experiment

### **Analysis**

Data can be

750 TB

- Data analysis steps
- Not all data is useful (runs)
- Intermediate data, code, scripts

#### **Publication**

- Findable, searchable, descriptive
- Citation, DOI reference
- Sometimes data is deposited (PDB, CXIDB)
- May use a subset of data, or data from many experiments

#### Re-use

- Check and verify results
- Improve the analysis
- Re-use code for new work
- Build on past data

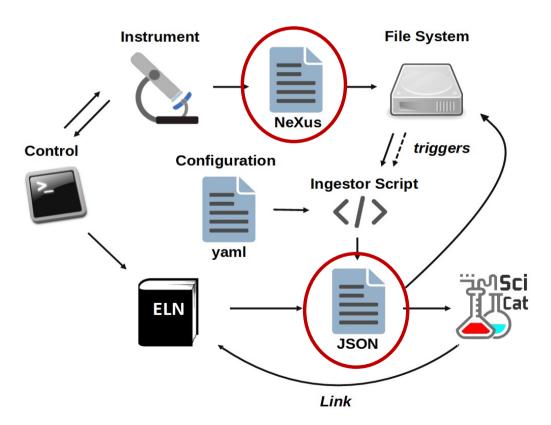


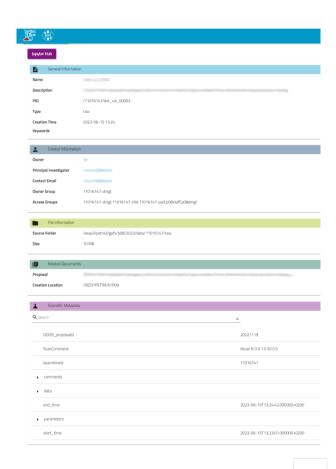




Collection of metadata from the instrument and operator side

- ☐ NeXus files gather all metadata from the instrument
- ☐ Metadata catalogue SciCat for critical metadata
  - Increased findability of datasets







## **NeXus File Format – Instrument Representation**



NeXus format for data at P08 in accordance with NeXus application definitions

☐ Division of LISA in DCD, sample and			Name	✓ ஆ lisa_dcd	Description	Type NXcollection	ShapeShape	Link
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NXcolleciton

## **Minimum Viable Metadata Specification**



Draft structure for minimal metadata schema by Philipp Jordt

☐ General schema for PaN techniques Dataset ☐ Necessary minimum for later understanding PID = 10 45678/1234 Title = Scan-1 ☐ Ideally including sufficient metadata for Is Public = true Type = Raw Start\_Date = 01.01.2023T01:23:45 (basic) analysis End Date = 01.01.2023T05:28:01 Related Datasets = 10.45678/5678, 10.45678/91011 Instrument [1..\*] Parameter [0..\*] Access Data File [1..\*] ID = 0Technique [1..\*] Ressource = /abc/xvz ID = 12345 Ressource = https://... PID = 10.12345/AuSi-1-2 ID = TP8034893489 Name = press1 Contact\_Person = John Doe Name = dataset1.nxs Name = P08 Ressource = sis.org/10.12345/AuSi-1-2 Ressource = https://. Description = Pressure Contact = john.doe@doeish.com Path = /abs/xyz/ Description = Beamline Name = AuSi-1-2 Name = X-ray Reflectivity Value = [12.4, ..., 11.9] License Type = CC BY 2.0 DE Size [GB] = 1 Owner = DESY Description = Sample details Description = More details. Unit = [Pa] License Ressource = https://creativecommons.org/licenses/by/2.0/de/ Data Dimensonality = 2 Facility = DESY Instrument ID = 4 Facility Ressource = https://desv.de

#### **Questions for discussion in ORSO**

- ☐ Are there *necessary extensions* in the specific context of reflectometry?
- What is a suitable set of *required* metadata in reflectometry? In particular, what needs to be carried on to the reduced reflectivities for further analysis?



# Summary

XRR use case at DESY/P08

- ☐ Workflows for the collection, curation and storage of metadata
- ☐ NeXus format with detailed instrument description with base classes
- ☐ Minimum metadata specification adaptable to reflectometry specifically

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